Se	arcn	Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/616,831	WENG ET AL.	
Examiner	Art Unit	<u></u> .
lames Kish	3737	

	SFAR	CHED	
	JEAN	OHED .	
Class	Subclass	Date	Examiner
601	2-4	6/20/2006	JMK
600	437, 439	6/20/2006	JMK

INI	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
			-
	1	<u> </u>	

SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
Performed Inventor Name Search	6/20/2006	JMK
Performed PLUS Search	6/19/2006	JMK
Performed IDS Search	6/19/2006	ЈМК
See attached Search History	6/20/2006	ЈМК